

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/519,824	BOEHM, MARTINA	
Examiner	Art Unit	
Bin Shen	1657	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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WE	ST	7/16/2007	BS	

SEARCH (INCLUDING SEAR		)
	DATE	EXMR
updated search.	7/12/2007	BS
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